

FDG311N

N-Channel 2.5V Specified PowerTrench® MOSFET

General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance. These devices are well suited for portable electronics applications.

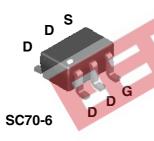
Applications

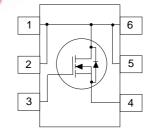
- Load switch
- Power management
- DC/DC converter

Features

• 1.9 A, 20 V.
$$R_{DS(ON)} = 0.115 \Omega$$
 @ $V_{GS} = 4.5 \text{ V}$ $R_{DS(ON)} = 0.150 \Omega$ @ $V_{GS} = 2.5 \text{ V}$.

- Low gate charge (3nC typical).
- High performance trench technology for extremely low R_{DS/OMD}.
- Compact industry standard SC70-6 surface mount package.





Absolute Maximum Ratings T_A = 25 C unless otherwise noted

3 A				
Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		20	V
V _{GSS}	Gate-Source Voltage		±8	V
I _D	Drain Current - Continuous	(Note 1a)	1.9	Α
	- Pulsed		6	
P _D	Power Dissipation for Single Operation	(Note 1a)	0.75	W
		(Note 1b)	0.48	
T _J , T _{stg}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

R IA	Thermal Resistance Junction-to-Ambient	(Note 1h)	260	°C/W

Package Marking and Ordering Information

	Device Marking	Device	Reel Size	Tape Width	Quantity	
,	.11	FDG311N	7	8mm	3000 units	

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics	•				•
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20			V
ΔBVpss ΔTJ	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		14		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 16 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate-Body Leakage Forward	$V_{GS} = 8 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
I _{GSS}	Gate-Body Leakage Reverse	V _{GS} = -8 V, V _{DS} = 0 V			-100	nA
On Chara	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.4	0.9	1.5	V
$\Delta VGS_{(th)}$ ΔT_J	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$, Referenced to $25^{\circ}C$		-3		mV/°C
R _{DS(on)}	Static Drain-Source On-Resistance	$\begin{aligned} V_{GS} &= 4.5 \text{ V}, & I_{D} &= 1.9 \text{ A} \\ V_{GS} &= 4.5 \text{ V}, & I_{D} &= 1.9 \text{ A}, \\ & T_{J} &= 125^{\circ}\text{C} \end{aligned}$	9_	0.082 0.110	0.115 0.170	Ω
I _{D(on)}	On-State Drain Current	$V_{GS} = 2.5 \text{ V}, I_{D} = 1.6 \text{ A}$ $V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$	4_	0.105	0.150	Α
	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 0.5 \text{ A}$	-47	6		S
grs .		VDS = 0 V, ID = 0.0 A				
<u>Dynamic</u> C _{iss}	Characteristics Input Capacitance	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$		270	ĺ	pF
	Output Capacitance	1 f = 1.0 MHz		55		рF
Coss				20		рF
C _{rss}	Reverse Transfer Capacitance			20		ρг
	g Characteristics (Note 2)	in the second				1
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 10 \text{ V}, I_{D} = 1 \text{ A},$ $V_{GS} = 5 \text{ V}, R_{GEN} = 6 \Omega$		5	12	ns
t _r	Turn-On Rise Time	VGS = 5 V, NGEN = 0 22		9	17	ns
t _{d(off)}	Turn-Off Delay Time			10	18	ns
t _f	Turn-Off Fall Time			2	6	ns
Qg	Total Gate Charge	$V_{DS} = 10 \text{ V}, I_D = 1.9 \text{ A},$		3	4.5	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 4.5 \text{ V}$		0.6		nC
Q _{gd}	Gate-Drain Charge			0.9		nC
Drain-So	urce Diode Characteristics a	and Maximum Ratings				
ls	Maximum Continuous Drain-Source	e Diode Forward Current			0.42	Α
V_{SD}	Drain-Source Diode Forward	V _{GS} = 0 V, I _S = 0.42 A (Note 2)		0.7	1.2	V

Notes:

^{1.} $R_{0,JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{0,JC}$ is guaranteed by design while $R_{0,CA}$ is determined by the user's board design.

a) 170°C/W when mounted on a 1 in² pad of 2oz copper.

b) 260° C/W when mounted on a minimum pad.

^{2.} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%

Typical Characteristics

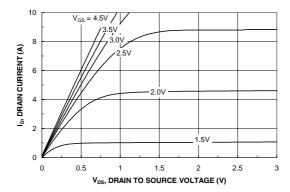


Figure 1. On-Region Characteristics.

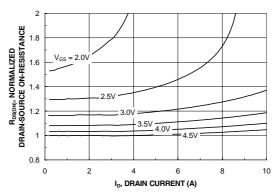


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

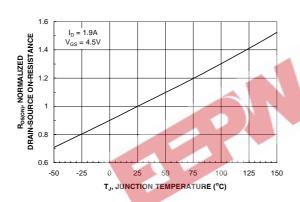


Figure 3. On-Resistance Variation with Temperature.

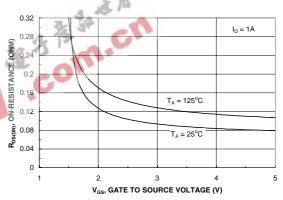


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

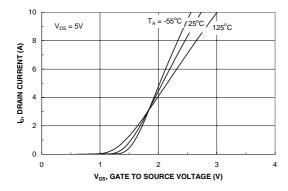


Figure 5. Transfer Characteristics.

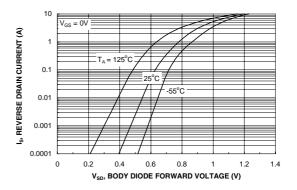
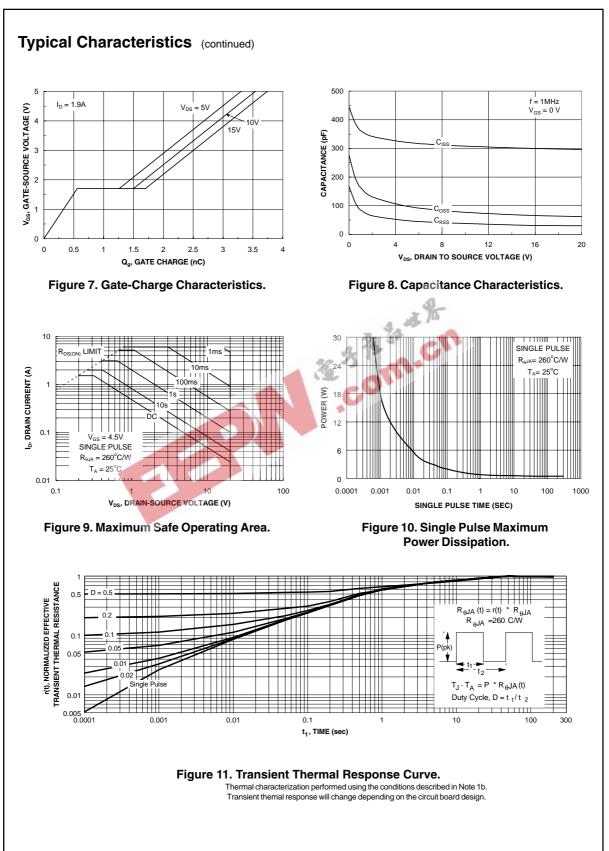


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.





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